Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/783,339	SMIDT ET AL.
Examiner	Art Unit

Jason Y. Pahng

3725

	SEARCHED				
Class	Subclass	Date	Examiner		
241	186.2	7/19/2005	JYP		
241	186.35	7/21/2005	JYP		
241	189.1	7/21/2005	JYP		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
		DATE	EXMR		
Keywords: wedge	7/	/21/2005	JYP		
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